APPLICA	BLE STAN	DARD									
	OPERATING TEMPERATUR	E RANGE	0500 TO (0500 (NOTEC 1)			STORAGE TEMPERATURE RANGE		-10°C TO +6	-10°C TO +60°C		
RATING	VOLTAGE		30V AC			APPLICABLE CONNECTOR		DF37*-10DS-0. 4V (
	CURRENT		0, 3A				-				
	CURRENT		SPECI	IFICA	TIOI	vs.					
	 ГЕМ	TEST METHOD					REQ	UIREMENTS	QT	AT	
	RUCTION	<u> </u>	TEOT METHOD								
GENERAL EXAMINATION		00111 1111122 110011221 11112 21112				ACCOR	DING TO D	RAWING.	X	X	
MARKING		INSTRUMENT. CONFIRMED VISUALLY.						X	 x		
	IC CHARA										
		20mV AC OR LESS 1khz,1m A .				100mΩ	MAX.		X	-	
INSULATION RESISTANCE		100V DC.				50MΩ MIN.			X		
VOLTAGE PROOF		100V AC FOR 1 min.				NO FLASHOVER OR BREAKDOWN.			Х	-	
MECHAI	VICAL CH	ARACTE	RISTICS								
INSERTION AND		MEASURED BY APPLICABLE CONNECTOR.				INSERTION FORCE 15.4 N MAX.					
WITHDRAWA	AL FORCES				EXTRACTION FORCE 2.6 N MIN.			X	<u> </u>		
MECHANIC OPERATION		10TIMES INSERTIONS AND EXTRACTIONS.				① CONTACT RESISTANCE: 100mΩ MAX. ② NO DAMAGE, CRACK OR LOOSENESS OF PARTS.				_	
VIBRATION		FREQUENCY 10 TO 55 TO 10 Hz,APPROX 5min, SINGLE AMPLITUDE 0.75 mm,10CYCLES, FOR 3 DIRECTIONS.				NO ELECTRICAL DISCONTINUITY OF 1 µs. NO DAMAGE, CRACK OR LOOSENESS OF PARTS.				-	
SHOCK		490 m/s ² DURATION OF PULSE 11 ms AT 3 TIMES FOR 3 DIRECTIONS.				1 NO ELECTRICAL DISCONTINUITY OF 1 µs. 2 NO DAMAGE, CRACK OR LOOSENESS OF PARTS.				_	
			ACTERISTICS						 1		
RAPID CHANGE OF TEMPERATURE		TEMPERATURE -55 → +85 °C TIME 30 → 30 min UNDER 5 CYCLES. (RELOCATION TIME TO CHAMBER: WITHIN 2~3 MIN)				① CONTACT RESISTANCE: 100mΩ MAX. ② INSULATION RESISTANCE: 50MΩ MIN. ③ NO DAMAGE, CRACK OR LOOSENESS OF PARTS.			_{N.} X	-	
DAMP HEAT (STEADY STATE)		EXPOSED AT 40 ± 2 °C, 90 TO 95 %, 96 h.				① CONTACT RESISTANCE: 100mΩ MAX. ② INSULATION RESISTANCE: 25MΩ MIN. ③ NO DAMAGE, CRACK OR LOOSENESS OF PARTS.			N. X		
SULPHUR DIIOXIDE		EXPOSED IN 25 PPM FOR 96h,25°C,75%. (REFER TO JIS C 60068)				① CONTACT RESISTANCE: 100mΩ MAX. ② NO DAMAGE, CRACK OR LOOSENESS OF PARTS.			1 1/	_	
SALT MIST		EXPOSE	EXPOSED IN 5% SALT MIST FOR 48h.			① CONTACT RESISTANCE: 100mΩ MAX. ② NO DAMAGE, CRACK OR LOOSENESS OF PARTS.				_	
			DRAV This is	VING subjec	FO	R R hange	EFER without	ENCE (M. 7. 5)			
Í	NT I	DESCRIPTI	ON OF REVISIONS		DESIC	SNED		CHECKED		ATE	
cou				1						07.0	
Δ				1			ADD	B 110 1/1//////////			
REMARKS		PERATURE	RISING BY CURRENT	<u> </u>			APPROVE		_	. 07. C	
REMARKS		IPERATURE	RISING BY CURRENT				APPROVE CHECKED DESIGNE	O KH. IKEDA	07.	. 07. 0	
REMARKS NOTE1: INC	LUDE THE TEM		RISING BY CURRENT	60512			CHECKE	D KH. IKEDA D KY. MIDORIKAWA	07. 07.	. 07. 0	
REMARKS NOTE1: INC	herwise spec	cified, refe	r to JIS C 5402 and IEC		D	RAWIN	CHECKEL DESIGNE DRAWN	D KH. IKEDA D KY. MIDORIKAWA	07. 07.	. 07. 0 . 06. 2 . 06. 2	
REMARKS NOTE1: INC	herwise spec	sified, refe				RAWIN T NO.	CHECKEI DESIGNE DRAWN G NO.	D KH. IKEDA D KY. MIDORIKAWA KY. MIDORIKAWA	07. 07. 07.	. 07. 0 . 06. 2 . 06. 2	



